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1. Scope

This specification applied to the products of Lead-Free current sensing resistor of metal foil for Lead-Free RLM series manufactured by TA-I TECHNOLOGY CO., LTD.

2. Type Designation

RLM10

 \mathbf{F}

T

 \mathbf{S}

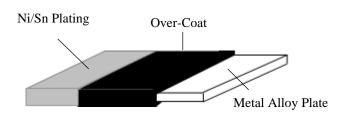
(M)

R003

Series No.	Tolerance	Packaging	Power	Metal	Resistance
10:0805(2012)	F= ±1%	T=Paper	B= 0.125W	M= MnCu	e.g.
12:1206(3216)	G= ±2%	E=Embossed	A= 0.25W		$R003=3m\Omega$
20:2010(5025)	J = ±5%	Tape	S= 0.5W		$R020=20m\Omega$
25: 2512(6432)			I= 0.75W		$R50m = 0.5m\Omega$
			C= 1W		
			D= 1.5W		
			E= 2W		
			G=3W		

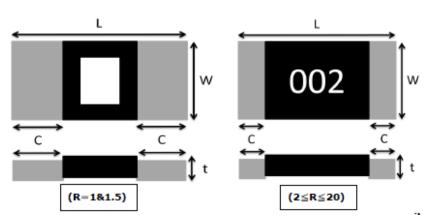
3. Construction and Dimension

3.1 Construction:



3.2 Dimension:





Type	L	W	С	t	Material
RLM10	2.0+0.1	1.25±0.1	$0.65\pm0.2(1 \le R < 2)$	0.6+0.20	Strip: Alloy
KLMIU	2.0±0.1	1.23±0.1	$0.4\pm0.2(2 \le R \le 25)$	0.0±0.20	Over Coating: molding Compound UL-94V-0 grade

UNIT: mm



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Marking

For RLM10

(1) If R=1&1.5, the marking pattern is a white rectangle.



(2) If $2 \le R \le 25$, the marking pattern is as follows.



Resistance value is expressed by 3 digits.

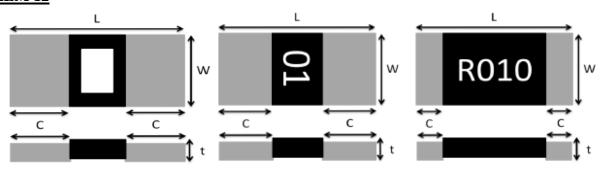
E.G.:

 $002 = 0.002\Omega = 2m\Omega$

 $010=0.010\Omega=10m\Omega$

*Note: If the marking pattern has underline, it is indicated as a MnCu material.

RLM 12



Type	L	W	С	t	Material	
	RLM12 3.2±0.20 1.6±0.20		$\begin{array}{c} 1.1 \pm 0.30 \\ (0.5 \text{m}\Omega \leq R < 2 \text{m}\Omega) \end{array}$	$\begin{array}{c} 1.1 \pm 0.20 \\ (0.5 \text{m}\Omega \! \leq \! R \! < \! 1 \text{m}\Omega) \end{array}$		
RLM12		3.2±0.20 1.6±0.20	0.5 ± 0.30	0.75 ± 0.20 $(1m\Omega \leq R < 2m\Omega)$	Metal: Alloy Over Coating: molding Compound UL-94 grade	
		0.5 ± 0.30 $(2m\Omega \le R \le 50m\Omega)$		$(2m\Omega \leq R \leq 50m\Omega)$	0.6 ± 0.20 $(2m\Omega \leq R \leq 50m\Omega)$	Compound OL-94 grade

UNIT: mm



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Marking

For RLM12

(1) If $0.5m\Omega \le R < 1m\Omega$, the marking pattern is a white rectangle.



(2) If $1m\Omega \le R < 2m\Omega$, the marking pattern is as follows



Resistance value is expressed by 2 digits.

E.G.:

 $01 = 0.001\Omega = 1m\Omega$

(3) If $2m\Omega \le R \le 50m\Omega$, the marking pattern is as follows



Resistance value is expressed by 4 digits.

E.G.:

 $R002 = 0.002\Omega = 2m\Omega$

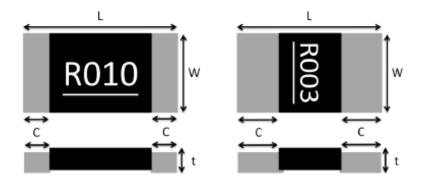
 $R010=0.010\Omega=10m\Omega$

*Note: If the marking pattern has underline, it is indicated as a MnCu material



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RLM 20



Type	L	W	С	t	Material
RLM20	5.0±0.2	2.5±0.2	$1.5\pm0.3(\leq 3\mathrm{m}\Omega)$	Strip: Alloy 0.6±0.20 Over Coating: poly	Strip: Alloy Over Coating: polymer
KLWI20	3.0±0.2	2.3±0.2	$0.6\pm0.3 (R>3m\Omega)$		Compound UL-94V-0 grade

UNIT: mm

Marking

For RLM20

(1) If $R \le 3m\Omega$, the marking pattern is as follows



Resistance value is expressed by 4 digits.

E.G.:

 $R003=0.003\Omega=3m\Omega$

(2) If $R>3m\Omega$, the marking pattern is as follows



Resistance value is expressed by 4 digits.

E.G.:

 $R005 = 0.005\Omega = 5m\Omega$

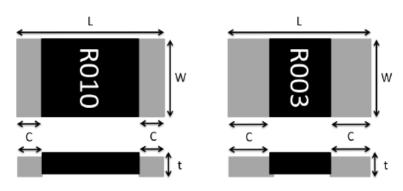
 $R010 = 0.010\Omega = 10m\Omega$

*Note: If the marking pattern has underline, it is indicated as a MnCu material



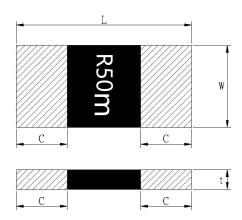
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<u>RLM25</u>



Type	L	W	С	t	Material
DI MOS	64.02	22.02	$2.2\pm0.2 (\leq 3 \text{m}\Omega)$	0.6 +0.20	Metal: Alloy
RLM25	6.4±0.2	3.2±0.2	$0.9\pm0.2(R>3m\Omega)$	0.6 ± 0.20	Over Coating: molding Compound UL-94V-0 grade

UNIT: mm



Style	L	W	C	t	Material
DI M25	DIM25 (4.02 22.02		$\begin{array}{c} 1.1 \pm 0.20 \\ (R \leq 0.30 \text{ m}\Omega) \end{array}$	Metal: Copper-Manganese Alloy	
RLM25	6.4±0.2	3.2±0.2	2.6±0.3		Over Coating: molding Compound UL-94V-0 grade

UNIT: mm



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Marking

For RLM25

(1) IF $R \le 3m\Omega$, the marking pattern is as follows



Resistance value is expressed by 4 digits.

E.G.:

 $R003 = 0.003\Omega = 3m\Omega$

(2) IF $R>3m\Omega$, the marking pattern is as follows



Resistance value is expressed by 4 digits.

E.G.:

 $R005 = 0.005\Omega = 5m\Omega$

 $R010 = 0.010\Omega = 10m\Omega$

(3) If $0.3\text{m}\Omega \leq R \leq 0.75\text{m}\Omega$, the marking pattern is as follows



Resistance value is expressed by 4 digits.

E.G.:

 $R30m = 0.0003\Omega = 0.3m\Omega$

 $R50m=0.0005\Omega=0.5m\Omega$

*Note: If the marking pattern has underline, it is indicated as a MnCu material



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4. Features

Туре	RLM10 (MnCu)	*RLM12 (MnCu/NiCu)	RLM20 (NiCu)			RLM25 RLM25 (MnCu) (MnCu)		
Size	0805	1206	20	010		2512		
Power Rating	0.125W 0.25W 0.5W	$\begin{array}{c} 0.5 \mathrm{m}\Omega \! \leq \! R \! < \! 1 \mathrm{m}\Omega \\ (0.25 \mathrm{W}, 0.5 \mathrm{W}, 1 \mathrm{W}, 1.5 \mathrm{W}) \\ 1 \mathrm{m}\Omega \! \leq \! R \! \leq \! 50 \mathrm{m}\Omega \\ (0.25 \mathrm{W}, 0.5 \mathrm{W}, 1 \mathrm{W}) \end{array}$	0.7	5W 75W W 5W	$\begin{array}{l} 1\mathrm{W}\left(R{=}0.5\mathrm{m}\Omega{\sim}50\mathrm{m}\Omega\right)\\ 1.5\mathrm{W}\left(1\mathrm{m}\Omega\leq R\leq 15\mathrm{m}\Omega\right)\\ 2\mathrm{W}\left(0.5\mathrm{m}\Omega\leq R\leq 10\mathrm{m}\Omega\right)\\ 3\mathrm{W}(0.3\mathrm{m}\Omega\leq R\leq 0.75\mathrm{m}\Omega) \end{array}$			
Resistance Value	1~25mΩ	0.5~50mΩ	2~50mΩ	1~50mΩ	1~50mΩ	0.3 ~0.75mΩ	1~50mΩ	
Operation Temperature Range	-55°C~+170°C							
TCR		±50nnm/9C	150 100			+50nnm/9C	±275 ppm/°C (R≦1mΩ)	
TCR		±50ppm/°C			±50ppm/°C	±50ppm/°C	±50ppm/°C (1mΩ <r≦50mω)< td=""></r≦50mω)<>	
Tolerance	±1% \ ±2% \ ±5%							
Insulation Resistance	Over $100 \mathrm{M}\Omega$							
Maximum Working Voltage(V)	$(P*R)^{1/2}$							

Note*:1 Watts with total solder pad and trace size of 300mm²

5. Reliability Tests

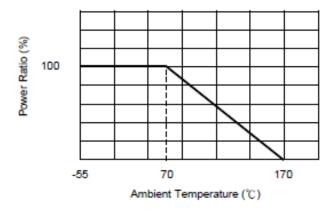
Test Items	Reference	Condition of Test	Test Limits
Temperature Coefficient of Resistance	IEC60115-1 4.8	+25 ~ 125°C	Refer 4.0
High Temperature Exposure (Storage)	AEC-Q200-REV D-Test 3 MIL-STD202 Method 108	T=170°C,1000hrs, Measurement at 24hrs after test conclusion.	< ±1%
Temperature Cycling	AEC-Q200-REV D-Test 4 JESD22 Method JA-104	1000Cycle (-55°C to 125°C) Measurement at 24hrs after test conclusion.	< ±0.5%
Short time overload	IEC60115-1 4.13	5 X rated power for 5s	< ±0.5%
Moisture Resistance	AEC-Q200-REV D-Test 6 MIL-STD-202 Method 106	T=24 hours / Cycle ,10 Cycles. Notes: Steps 7a& 7b not required. Unpowered	<±1%
Biased Humidity	AEC-Q200-REV D-Test 7 MIL-STD-202 Method 103	10% Rated power at 85°C, RH:85%, 1000Hrs, Measurement at 24hrs after test conclusion.	< ±0.5%
Operation life	AEC-Q200-REV D-Test 8 MIL-STD-202 Method 108	1000 hours TA=125°C at 45% rated power. Measurement at 24±4 hours after test conclusion.	<±1%
External Visual	AEC-Q200-REV D-Test 9 MIL-STD-883 Method 2009	Electrical test not required. Inspect device construction, marking and workmanship	



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Physical Dimension	AEC-Q200-REV D-Test 10 JESD22 Method JB-100	Verify physical dimensions to the applicable device detail specification. Note: User(s) and Suppliers spec. Electrical test not required.	
Resistance to Solvents	AEC-Q200-REV D-Test 12 MIL-STD-202 Method 215	a: Isopropyl Alcohol: Mineral Spirits= 1:3 b: Terpene Defluxer (Bioact EC-7R) c: Deionized water: Propylene Glycol Monomethyl Ether: monoethanolamine =42:1:1	Marking and protective layer Cannot be detached
Resistance to Soldering Heat	AEC-Q200-REV D-Test 15 MIL-STD-202 Method 210	T=260+/-5°C solder,10+/-1 sec dwell	< ±0.5%
Mechanical Shock	AEC-Q200-REV D-Test 13 MIL-STD-202 Method 213	100g's, Normal duration is 6ms, half sine shock pulse	< ±0.5%
Resistance to vibration	AEC-Q200-REV D-Test 14 MIL-STD-202 Method 204	5g's for 20min.12cycles, 10-2000Hz	<±0.5%
Board Flex	AEC-Q200-REV D-Test 21 AEC-Q200-005	Min 2mm deflection ,60sec.	< ±0.5%
Flammability	AEC-Q200-REV D-Test 20 UL-94	V-0 or V-1 are acceptable, Electrical test not required	V-0
Thermal Shock	AEC-Q200-REV D-Test 16 MIL-STD-202 Method 107	-55°C/+155°C. Note: Number of cycles required-300, Maximum transfer time-20 seconds, Dwell time-15 minutes. Air-Air.	< ±1.0%
ESD	AEC-Q200-REV D-Test 17 AEC-Q200-002 or ISO/DIS 10605	verify the voltage setting at 500V	<±1.0%
Solderability	AEC-Q200-REV D-Test 18 J-STD-002	Method B, aging 4 hours at 155 °C dry heat Lead-free solder bath at 235±3 °C Dipping time: 3±0.5 seconds	> 95% area covered with tin
Terminal Strength (SMD)	AEC-Q200-REV D-Test 22 AEC-Q200-006	Force of 1.8kg for 60 seconds Remarks: 0201-NA	< ±1.0%

5.1 Derating Curve





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5.2 Rated Current

The rated current is calculated by the following formula:

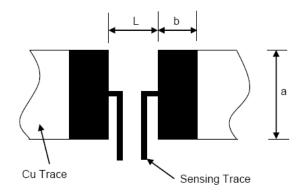
$$I = \sqrt{\mathbf{P} \div \mathbf{R}}$$

I: Rated Current (A)

P: Rated Power (W)

R: Resistance Value (Ω)

6. Recommended Solder Pad Dimension



Type	Resistance Range(m Ω)	a	b	L
RLM10	$1 \le R < 2$	1.4±0.1	1.15±0.1	0.7±0.1
	$2 \leq R \leq 25$	1.4±0.1	1.15±0.1	1.2±0.1
RLM12	R < 2	1.8±0.1	2.3±0.1	1.0±0.1
KLW112	$2 \leq R < 50$	1.8±0.1	1.7±0.1	1.6±0.1
RLM20	2~3	3.4±0.2	3.5±0.2	2.0±0.2
(NiCu)	4~50	3.4±0.2	1.5±0.2	3.5±0.2
RLM20	1~3	3.4±0.2	3.5±0.2	2.0±0.2
(MnCu)	4~50	3.4±0.2	1.5±0.2	3.5±0.2
	1~3	4.0±0.1	3.1±0.1	1.3±0.1
RLM25	4~50	4.0±0.1	2.1±0.1	4.1±0.1
	0.3~0.75	4.0±0.1	3.1±0.1	1.3±0.1

Unit: mm

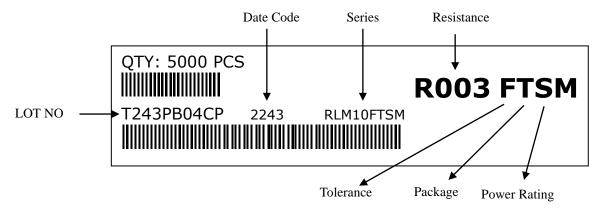


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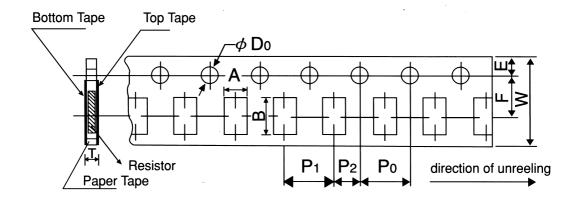
7. Number of Package

Type	RLM 10	RLM 12	RLM 20	RLM 25
D:	5000	$3000 (0.5 \text{m}\Omega \leq R < 1 \text{m}\Omega)$	4000	2000 (R≦0.30 mΩ)
Pieces	5000	$5000 \\ (1\text{m}\Omega \leq R \leq 50\text{m}\Omega)$	4000	4000 $(0.5 \text{ m}\Omega \leq R \leq 50 \text{ m}\Omega)$

8. Label



9. Packaging

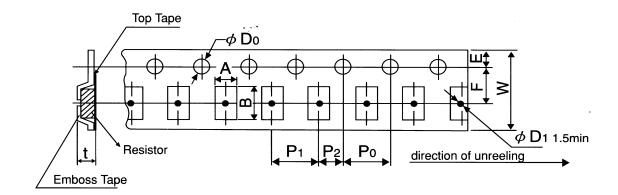


Packing	Type	A	В	W	F	Е	P_1	P ₂	P_0	$\phi\mathrm{D}_0$	T
Paper Tape	RLM10	1.6 ±0.15	2.4 ±0.2	8.0 ±0.2	3.5 ±0.05	1.75 ±0.1	4.0 ±0.1	2.0 ±0.1	4.0 ±0.1	ψ 1.5 (+0.1/-0)	0.84 ±0.1
raper rape	RLM12	2.0 ±0.15	3.6 ±0.2	8.0. ±0.2	3.5 ±0.05	1.75 ±0.1	4.0 ±0.1	2.0 ±0.05	4.0 ±0.1	ψ 1.5 (+0.1/-0)	0.84 ±0.1

Unit: mm



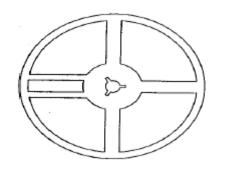
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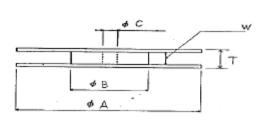


Packing	Type	A_0	B_0	W	F	E	P	P_2	P_0	$\phi\mathrm{D}0$	t
Embossed Tape	RLM12	1.78 ±0.1	3.5 ±0.1	8.0 ±0.2	3.5 ±0.05	1.75 ±0.1	4.0 ±0.1	2.0 ±0.05	4.0 ±0.1	φ 1.5 (+0.1/-0)	1.27 ±0.1
	RLM20	2.8 ±0.2	5.3 ±0.2	12 ±0.2	5.5 ±0.05	1.75 ±0.1	4.0 ±0.1	2.0 ±0.05	4.0 ±0.05	ψ 1.5 (+0.1/-0)	0.85 ±0.15
	$\begin{array}{c} RLM25 \\ (R \leq 0.30 \text{ m}\Omega) \end{array}$	3.6 (+0.2/-0.18)	6.9 ±0.2	12 ±0.2	5.5 ±0.05	1.75 ±0.1	4.0 ±0.1	2.0 ±0.05	4.0 ±0.05	ψ 1.5 (+0.1/-0)	1.5 ±0.15
	$ \begin{array}{c} RLM25 \\ (0.5 \ m \Omega \leq R \\ \leq 50m \Omega) \end{array} $	3.6 (+0.2/-0.18)	6.9 ±0.2	12 ±0.2	5.5 ±0.05	1.75 ±0.1	4.0 ±0.1	2.0 ±0.05	4.0 ±0.05	ψ 1.5 (+0.1/-0)	0.85 ±0.15

Unit: mm

10. Reel Specification





Series	ϕ A	$\phi\mathrm{B}$	ϕ C	W	T
RLM 10	178.0 ±2.0	60.0 ± 1.0	13.0 ± 1.0	9.0 ± 1.0	11.4 ±1.0
RLM 12	178.0 ±2.0	60.0 ±1.0	13.0 ±1.0	9.0 ±1.0	11.5±1.0
RLM 20	178.0 ±2.0	60.0 ±1.0	13.0 ±1.0	13.0 ±1.0	15.5 ±1.0
RLM 25	180(+0/-3)	60.0 ±1.0	13.0 ±1.0	13.0 ±1.0	15.4±2.0

Unit: mm

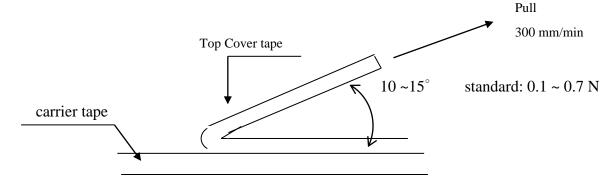


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11. Peeling Strength of Top Cover Tape

Peel – off force of paper and blister tape is in accordance with "JIS"

Test Condition: 0.1 to 0.7 N at a peel-off speed of 300 mm / min.



12. Storage Conditions:

Temperature: 5°C~35°C, Humidity:40%~75%

Humidity storage level: Level 1

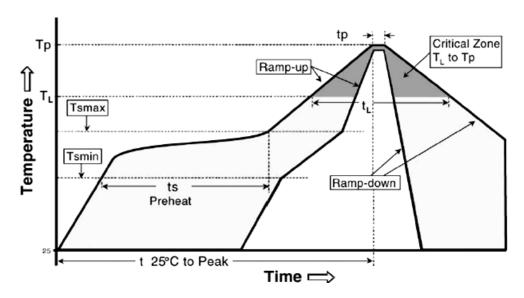
13. Shelf Life:

2 years from manufacturing date.



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14. Recommend IR – Reflow profile: (solder: Sn96.5 / Ag3 / Cu0.5)



Alloyed Re-flow times: 3 times

Remark: To avoid discoloration phenomena of chip on terminal electrodes,

please use N2 Re-flow furnace.

Iron Solder:350±10°C, 3+1/-0 sec,1 time

Profile Feature	Lead (Pb)-Free Assembly	
Average ramp-up rate (Tsmax to Tp)	3°C / second max	
Preheat		
- Temperature Min (Tsmin)	150°C	
- Temperature Max (Tsmax)	200°C	
- Time (Tsmin to Tsmax) (ts)	60 -120 seconds	
Time maintained above:		
- Temperature (TL)	217°C	
- Time (TL)	60-150 seconds	
Peak Temperature (Tp)	260°C	
Time within +0/-5°C of actual Peak Temperature (tp) ²	10 seconds	
Ramp-down Rate	6°C/second max.	
Time 25°C to Peak Temperature	8mimutes max.	



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15. ECN

Engineering Change Notice: The customer will be informed with ECN if there is significant modification on the characteristics and materials described in Approval Sheet.

16. Manufacturing Country & City:

TA-I TECHNOLOGY CO., LTD. (Taiwan- Tao Yuan)

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单击下面可查看定价,库存,交付和生命周期等信息

>>TA-I(大毅)